

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination ISHIMURA ET AL.
	Examiner Thien F Tran	Art Unit 2811

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5,962,877	10-1999	Sakurai et al.	257/133
B	US-4,903,117	02-1990	Okamoto et al.	257/751
C	US-6,229,166	05-2001	Kim et al.	257/295
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J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 11-284176	10-1999	Japan	Sakurai et al.	
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Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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